



## Shenzhen Huaxia Testing Technology Co., Ltd

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Report Template Version: V03  
Report Template Revision Date: Mar.1st, 2017

# RF Exposure Evaluation Report

**Report No. :** CQASZ20190600033EX-02

**Applicant:** JMTek Industries(Shenzhen) Co., Ltd.

**Address of Applicant:** 14G, Innovation Tech Building, Quanzhi Science and Technology innovation Park, ShaJing Street, Baoan District, ShenZhen, China

**Manufacturer:** JMTek Industries(Shenzhen) Co., Ltd.

**Address of Manufacturer:** 14G, Innovation Tech Building, Quanzhi Science and Technology innovation Park, ShaJing Street, Baoan District, ShenZhen, China

**Equipment Under Test (EUT):**

**Product:** Wireless Charger

**Model No.:** WPC488-10W

**Brand Name:** N/A

**FCC ID:** 2APU5-WPC488-10W

**Standards:** 47 CFR Part 1.1307  
47 CFR Part 1.1310  
KDB 680106 D01 RF Exposure Wireless Charging Base App v03

**Date of Test:** Jun. 24, 2019 to Jun. 28, 2019

**Date of Issue:** Jul. 01, 2019

**Test Result :** **PASS\***

**Tested By:**

*Tom Chen*

(Tom Chen)

**Reviewed By:**

*Aaron Ma*

(Aaron Ma)

**Approved By:**

*Jack Ai*

( Jack Ai)



\* In the configuration tested, the EUT complied with the standards specified above.

The test report is effective only with both signature and specialized stamp, The result(s) shown in this report refer only to the sample(s) tested. Without written approval of CQA, this report can't be reproduced except in full.

## 2 Version

### Revision History Of Report

| Report No.            | Version | Description    | Issue Date    |
|-----------------------|---------|----------------|---------------|
| CQASZ20190600033EX-02 | Rev.01  | Initial report | Jul. 01, 2019 |

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## 4 General Information

### 4.1 Client Information

|                          |                                                                                                                                |
|--------------------------|--------------------------------------------------------------------------------------------------------------------------------|
| Applicant:               | JMTek Industries(Shenzhen) Co., Ltd.                                                                                           |
| Address of Applicant:    | 14G, Innovation Tech Building, Quanzhi Science and Technology innovation Park, ShaJing Street, Baoan District, ShenZhen, China |
| Manufacturer:            | JMTek Industries(Shenzhen) Co., Ltd.                                                                                           |
| Address of Manufacturer: | 14G, Innovation Tech Building, Quanzhi Science and Technology innovation Park, ShaJing Street, Baoan District, ShenZhen, China |

### 4.2 General Description of EUT

|                      |                                                                                                                                                                        |
|----------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Product Name:        | Wireless Charger                                                                                                                                                       |
| Model No.:           | WPC488-10W                                                                                                                                                             |
| Trade Mark:          | N/A                                                                                                                                                                    |
| Hardware Version:    | /                                                                                                                                                                      |
| Software Version:    | /                                                                                                                                                                      |
| Operation Frequency: | 172.2KHz                                                                                                                                                               |
| Modulation Type:     | Induction                                                                                                                                                              |
| Antenna Type:        | Loop coil antenna                                                                                                                                                      |
| Antenna Gain:        | 0 dBi                                                                                                                                                                  |
| Charger Information: | Input: 5V $\overline{=}$ 2A; 9V $\overline{=}$ 1.67A<br>Wireless Output: 5V $\overline{=}$ 1A(5W), 9V $\overline{=}$ 1.1A(10W)<br>USB Output: 5V $\overline{=}$ 1A Max |

*Note: For more detailed features description, please refer to the manufacturer's specifications or the User's Manual.*

### 4.3 Test Environment

| Operating Environment: |                                          |
|------------------------|------------------------------------------|
| Temperature:           | 25.0 °C                                  |
| Humidity:              | 53 % RH                                  |
| Atmospheric Pressure:  | 1001mbar                                 |
| Test Mode:             |                                          |
| Mode a:                | Wireless charging Mode at 9V (Full load) |
| Mode b:                | Wireless charging Mode at 9V (half load) |
| Mode c:                | Wireless charging Mode at 9V (Null load) |
| Mode d:                | Wireless charging Mode at 5V (Full load) |
| Mode e:                | Wireless charging Mode at 5V (half load) |
| Mode f:                | Wireless charging Mode at 5V (Null load) |

### 4.4 Description of Support Units

The EUT has been tested with associated equipment below.

| Description              | Manufacturer | Model No.    | emark             | FCC certification |
|--------------------------|--------------|--------------|-------------------|-------------------|
| Adapter                  | Samsung      | EP-TA50CBC   | Provide by client | Verification      |
| Adapter                  | HUAWEI       | HW-050450C00 | Provide by client | Verification      |
| Wireless electronic Load | -            | -            | Provide by client | -                 |

## 4.5 Test Location

Shenzhen Huaxia Testing Technology Co., Ltd,

1F., Block A of Tongsheng Technology Building, Huahui Road, Dalang Street, Longhua District, Shenzhen, China

## 4.6 Test Facility

• **A2LA (Certificate No. 4742.01)**

Shenzhen Huaxia Testing Technology Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 4742.01.

• **FCC Registration No.: 522263**

Shenzhen Huaxia Testing Technology Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.:522263

## 4.7 Equipment List

| Test Equipment        | Manufacturer                     | Model No. | Instrument No. | Calibration Date | Calibration Due Date |
|-----------------------|----------------------------------|-----------|----------------|------------------|----------------------|
| Broadband Field Meter | Narda Safety Test Solutions GmbH | NBM-520   | SB9873         | 2018/10/18       | 2019/10/17           |
| Magnetic field probe  | HIOKI                            | 3470      | SB9058/04      | 2018/12/14       | 2019/12/13           |

## 5 RF Exposure Evaluation

### 5.1 RF Exposure Compliance Requirement

#### 5.1.1 Limits

According to FCC Part1.1310: The criteria listed in the following table shall be used to evaluate the environment impact of human exposure to radio frequency (RF) radiation as specified in part1.1307(b)

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

| Frequency range<br>(MHz)                                       | Electric field<br>strength<br>(V/m) | Magnetic field<br>strength<br>(A/m) | Power density<br>(mW/cm <sup>2</sup> ) | Averaging time<br>(minutes) |
|----------------------------------------------------------------|-------------------------------------|-------------------------------------|----------------------------------------|-----------------------------|
| <b>(A) Limits for Occupational/Controlled Exposures</b>        |                                     |                                     |                                        |                             |
| 0.3–3.0 .....                                                  | 614                                 | 1.63                                | *(100)                                 | 6                           |
| 3.0–30 .....                                                   | 1842/f                              | 4.89/f                              | *(900/f <sup>2</sup> )                 | 6                           |
| 30–300 .....                                                   | 61.4                                | 0.163                               | 1.0                                    | 6                           |
| 300–1500 .....                                                 | .....                               | .....                               | f/300                                  | 6                           |
| 1500–100,000 .....                                             | .....                               | .....                               | 5                                      | 6                           |
| <b>(B) Limits for General Population/Uncontrolled Exposure</b> |                                     |                                     |                                        |                             |
| 0.3–1.34 .....                                                 | 614                                 | 1.63                                | *(100)                                 | 30                          |
| 1.34–30 .....                                                  | 824/f                               | 2.19/f                              | *(180/f <sup>2</sup> )                 | 30                          |
| 30–300 .....                                                   | 27.5                                | 0.073                               | 0.2                                    | 30                          |
| 300–1500 .....                                                 | .....                               | .....                               | f/1500                                 | 30                          |
| 1500–100,000 .....                                             | .....                               | .....                               | 1.0                                    | 30                          |

Note 1: f = frequency in MHz ; \*Plane-wave equivalent power density

Note 2: For the applicable limit, see FCC 1.1310, 680106 D01 RF Exposure Wireless Charging Apps v03

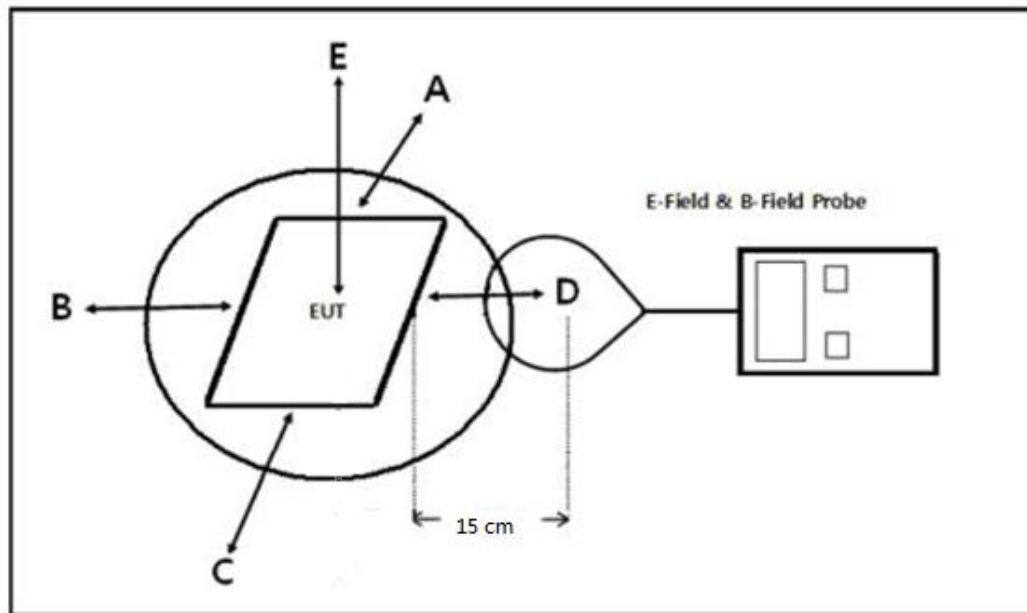
Note 3: Emissions between 100 kHz to 300 kHz should be assessed versus the limits at 300 kHz in Table 1 of Section 1.1310: 614 V/m and 1.63 A/m. A KDB inquiry is required to determine the applicable exposure limits below 100 kHz.

Note 4: The aggregate H-field strengths at 15 cm surrounding the device and 20 cm above the top surface from all simultaneous transmitting coils are demonstrated to be less than 50% of the MPE limit .

#### 5.1.2 Test Procedure

For devices designed for typical desktop applications, such a wireless charging pads, RF exposure evaluation should be conducted assuming a user separation distance of 20 cm(Top) and 15cm(Edge). E and H field strength measurements or numerical modeling may be used to demonstrate compliance. Measurements should be made from all sides and the top of the primary/client pair, with the 20 cm(Top) and 15cm(Edge) measured from the center of the probe(s) to the edge of the device.

### 5.1.3 Test Setup



Note: Position A: Front of EUT; Position B: Left of EUT; Position C: back of EUT; Position D: Right of EUT; Position E: Top of EUT(20 cm measure distance);

### 5.1.4 Test Results

The EUT does comply with item 5 KDB680106 D01 v03.

(1) Power transfer frequency is less than 1 MHz.  
(Conform)

(2) Output power from each primary coil is less than or equal to 15 watts.  
(Conform)

(3) The transfer system includes only single primary and secondary coils. This includes charging systems that may have multiple primary coils and clients that are able to detect and allow coupling only between individual pairs of coils.  
(Conform)

(4) Client device is placed directly in contact with the transmitter.  
(Conform)

(5) Mobile exposure conditions only (portable exposure conditions are not covered by this exclusion).  
(Conform)

(6) The aggregate H-field strengths at 15 cm surrounding the device and 20 cm above the top surface from all simultaneous transmitting coils are demonstrated to be less than 50% of the MPE limit.  
(Conform)



Test condition: Mode a

E-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(V/m) | Probe<br>Position B<br>(V/m) | Probe<br>Position C<br>(V/m) | Probe<br>Position D<br>(V/m) | Probe<br>Position E<br>(V/m) | Limit<br>(V/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.19                         | 0.20                         | 0.18                         | 0.18                         | 2.15                         | 614            |

H-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(A/m) | Probe<br>Position B<br>(A/m) | Probe<br>Position C<br>(A/m) | Probe<br>Position D<br>(A/m) | Probe<br>Position E<br>(A/m) | Limit<br>(A/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.08                         | 0.11                         | 0.10                         | 0.11                         | 0.72                         | 1.63           |

Test condition: Mode b

E-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(V/m) | Probe<br>Position B<br>(V/m) | Probe<br>Position C<br>(V/m) | Probe<br>Position D<br>(V/m) | Probe<br>Position E<br>(V/m) | Limit<br>(V/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.11                         | 0.14                         | 0.15                         | 0.16                         | 0.89                         | 614            |

H-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(A/m) | Probe<br>Position B<br>(A/m) | Probe<br>Position C<br>(A/m) | Probe<br>Position D<br>(A/m) | Probe<br>Position E<br>(A/m) | Limit<br>(A/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.10                         | 0.14                         | 0.08                         | 0.10                         | 0.70                         | 1.63           |

Test condition: Mode c

E-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(V/m) | Probe<br>Position B<br>(V/m) | Probe<br>Position C<br>(V/m) | Probe<br>Position D<br>(V/m) | Probe<br>Position E<br>(V/m) | Limit<br>(V/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.08                         | 0.12                         | 0.07                         | 0.08                         | 0.59                         | 614            |

H-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(A/m) | Probe<br>Position B<br>(A/m) | Probe<br>Position C<br>(A/m) | Probe<br>Position D<br>(A/m) | Probe<br>Position E<br>(A/m) | Limit<br>(A/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.07                         | 0.12                         | 0.11                         | 0.12                         | 0.75                         | 1.63           |

Test condition: Mode d

E-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(V/m) | Probe<br>Position B<br>(V/m) | Probe<br>Position C<br>(V/m) | Probe<br>Position D<br>(V/m) | Probe<br>Position E<br>(V/m) | Limit<br>(V/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.09                         | 0.09                         | 0.10                         | 0.11                         | 0.90                         | 614            |

H-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(A/m) | Probe<br>Position B<br>(A/m) | Probe<br>Position C<br>(A/m) | Probe<br>Position D<br>(A/m) | Probe<br>Position E<br>(A/m) | Limit<br>(A/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.09                         | 0.07                         | 0.11                         | 0.06                         | 0.67                         | 1.63           |

Test condition: Mode e

E-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(V/m) | Probe<br>Position B<br>(V/m) | Probe<br>Position C<br>(V/m) | Probe<br>Position D<br>(V/m) | Probe<br>Position E<br>(V/m) | Limit<br>(V/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.11                         | 0.11                         | 0.08                         | 0.11                         | 0.92                         | 614            |

H-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(A/m) | Probe<br>Position B<br>(A/m) | Probe<br>Position C<br>(A/m) | Probe<br>Position D<br>(A/m) | Probe<br>Position E<br>(A/m) | Limit<br>(A/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.09                         | 0.08                         | 0.06                         | 0.10                         | 0.65                         | 1.63           |

Test condition: Mode f

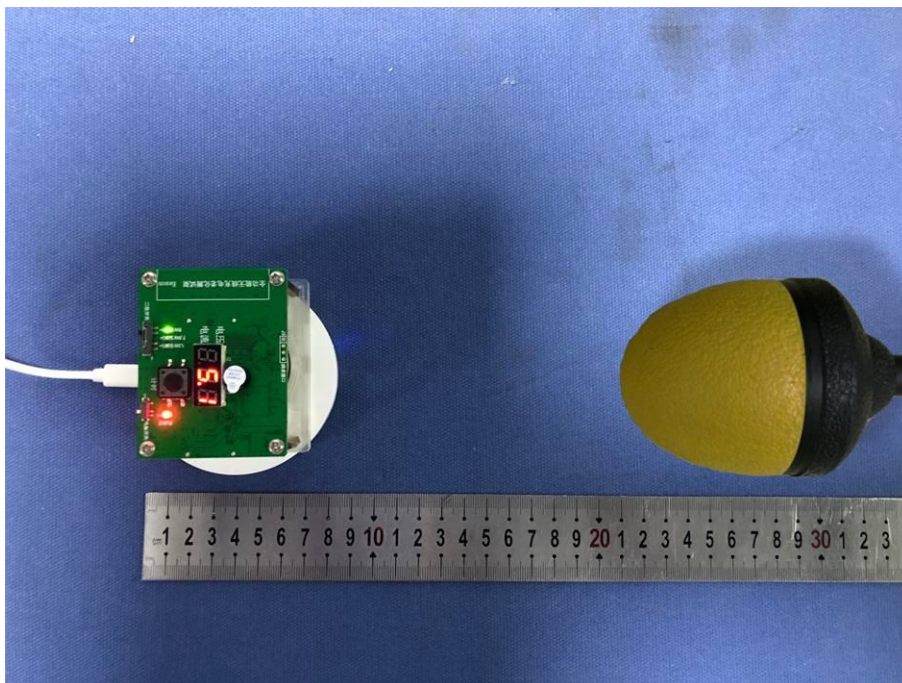
E-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(V/m) | Probe<br>Position B<br>(V/m) | Probe<br>Position C<br>(V/m) | Probe<br>Position D<br>(V/m) | Probe<br>Position E<br>(V/m) | Limit<br>(V/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.15                         | 0.13                         | 0.13                         | 0.09                         | 0.90                         | 614            |

H-field strength test result:

| Frequency<br>Range | Probe<br>Position A<br>(A/m) | Probe<br>Position B<br>(A/m) | Probe<br>Position C<br>(A/m) | Probe<br>Position D<br>(A/m) | Probe<br>Position E<br>(A/m) | Limit<br>(A/m) |
|--------------------|------------------------------|------------------------------|------------------------------|------------------------------|------------------------------|----------------|
| 172.2KHz           | 0.11                         | 0.06                         | 0.08                         | 0.09                         | 0.67                         | 1.63           |

## APPENDIX A: PHOTOGRAPHS OF TEST SETUP



----END OF REPORT----